Basic Error Analysis

Physics 403

Eugene V Colla

D. Hertzog

A. Bezryadin

Outline of the lecture

- **Errors and uncertainties**

- **The reading error**

- **Accuracy and precession**

- **Systematic and statistical errors**

- **Fitting errors**

- **Presentation of the results**

Introduction

- Uncertainties exist in all experiments

- The final goal of any experiment is to obtain *reproducible* results. Knowing errors and uncertainties is an essential part for ensuring reproducibility.

- To know the uncertainties, we use two approaches:

(1) Repeat each measurement many times and determine how well the result reproduces itself. The results are always at least slightly different. These differences represent **statistical errors**.

(2) Measure the quantity of interest using a different method. The results, if correct, are independent of the measurement technique. If the results are consistently different then there are **systematic errors** in one of the methods or in both.

(3) **Presenting the result of your experiment: Use the right number of significant digits, in agreement with the estimated uncertainty.**
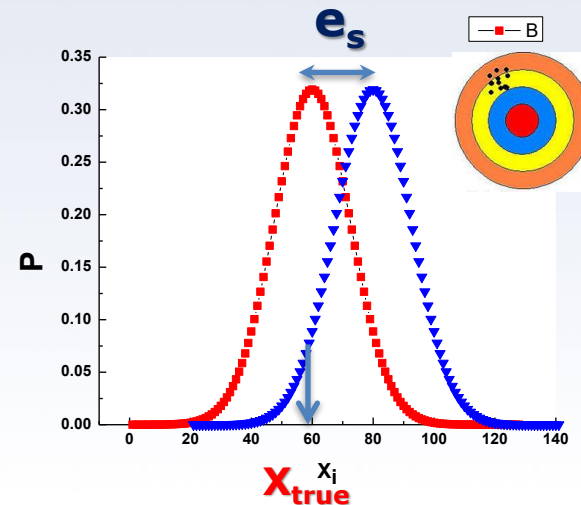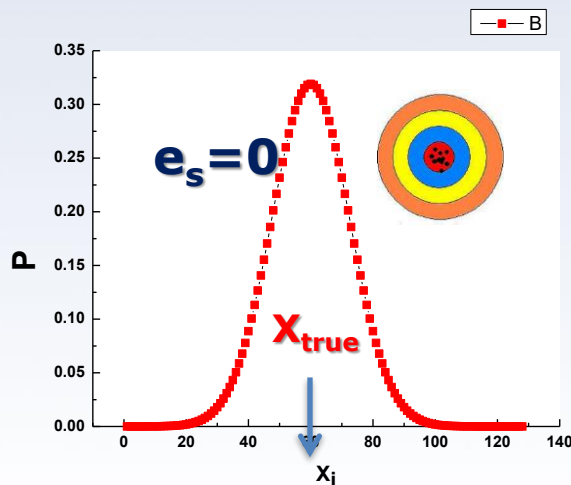
Errors (uncertainties)

Result of measurement

Systematic error

$$X_{meas} = X_{true} + e_s + e_r$$

Correct value

Random error

Probability distribution of the measured value.
Left: statistical errors. Right: statistical and systematic errors.

Systematic vs. Statistical Uncertainties

- Systematic uncertainty

  – Uncertainties associated with imperfect knowledge of measurement **apparatus**, other physical **quantities** needed for the measurement, or the physical **model** used to interpret the data.

  – Generally correlated between measurements. Cannot be reduced by multiple measurements.

  – Better calibration, or measurements employing different techniques or methods can reduce the uncertainty.

- Statistical Uncertainty

  – Uncertainties due to stochastic fluctuations of molecules and photons and vibrations etc.

  – Generally, there is no correlation between stocastic errors of successive measurements.

  – Multiple measurements can be used to reduce this uncertainty.
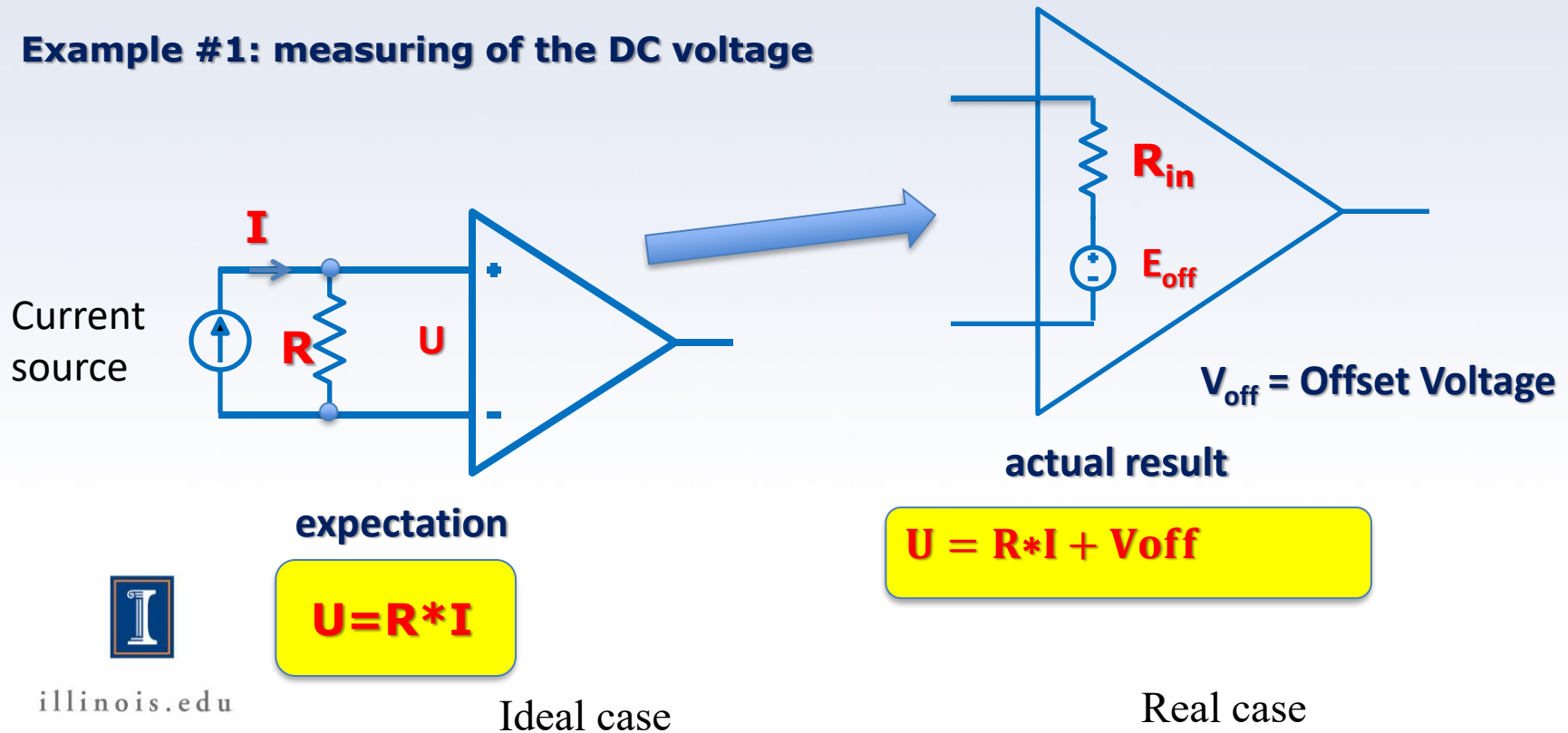
Example of Systematic Error

- For example, if your measuring tape has been stretched out, your results will always be lower than the true value. Similarly, if you're using scales that haven't been set to zero beforehand, there will be a systematic error resulting from the mistake in the calibration. Such errors cannot be reduced simply by repeating the measurement and averaging the results. Such errors can be reduced by analyzing the instrument(s) used for the measurement and by using different instruments.
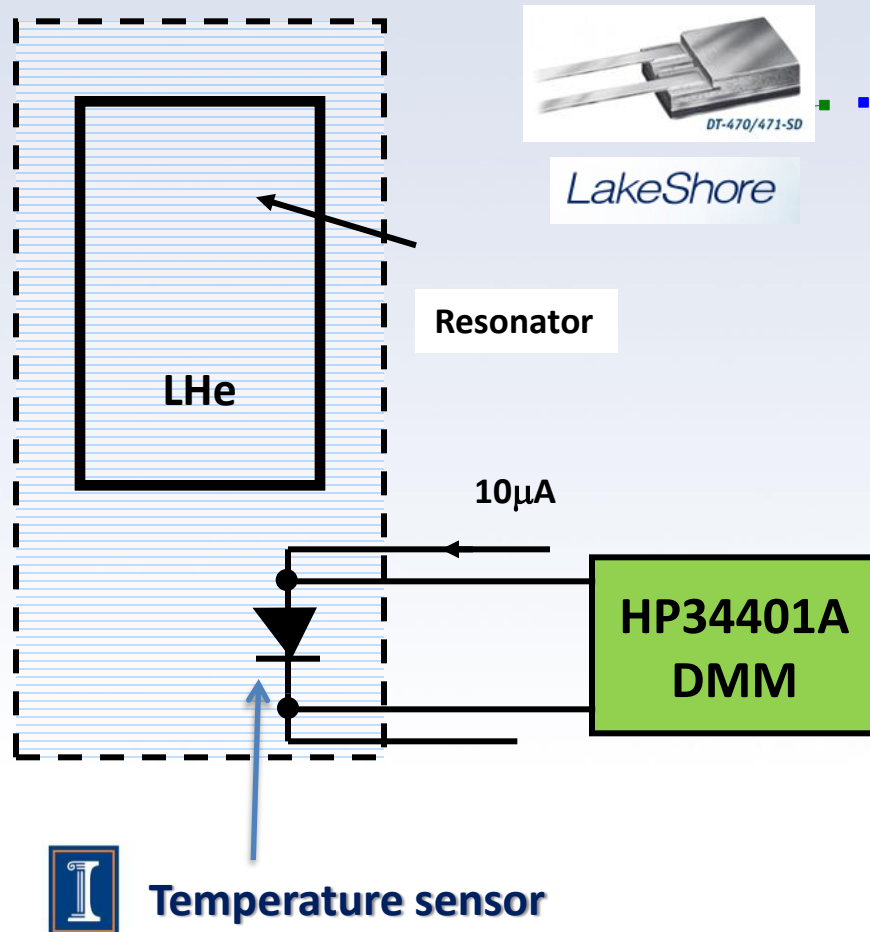
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Sources of systematic errors: **poor calibration of the equipment, changes of environmental conditions, imperfect method of observation, drift and some offset in readings etc.**
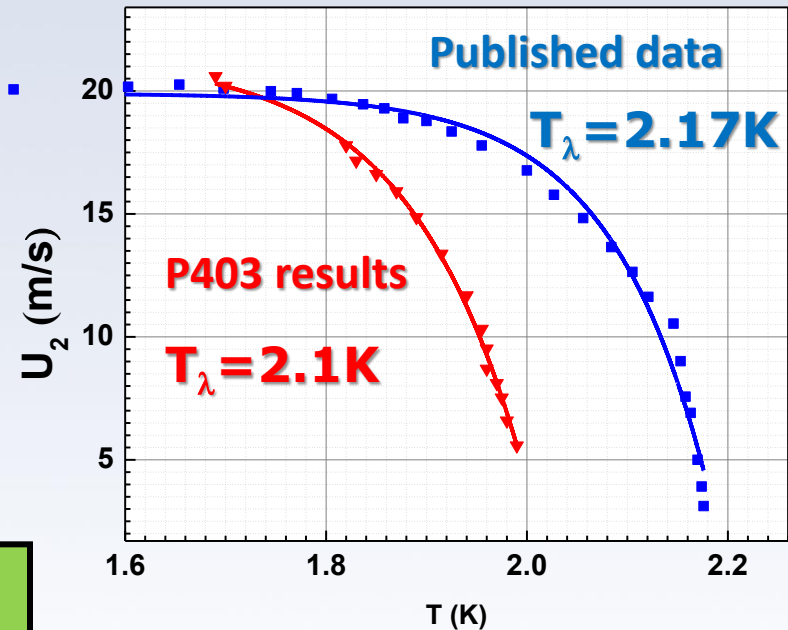
Example #1: measuring of the DC voltage

R_{in}

E_{off}

I

Current source

R

U

V_{off} = Offset Voltage

actual result

expectation

$$U = R*I + Voff$$

$$U=R*I$$

Ideal case

Real case

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Example: Systematic errors in temperature measurements

Example #3: poor calibration

Measuring of the speed of the second sound in superfluid He4

Resonator

LHe

DT-470/471-SD

LakeShore

10μA

HP34401A DMM

Temperature sensor

Published data

$T_\lambda = 2.17K$

P403 results

$T_\lambda = 2.1K$

U_2 (m/s) vs T (K)

Definitions (NIST)

**The standard uncertainty σ of a measurement result x is the estimated standard deviation of x.**

(The relative standard uncertainty σ_r of a measurement result x is defined by $\sigma_r = \sigma /|x|$, where x is not equal to 0.)

In statistics, the standard deviation (**SD, also represented by the Greek letter sigma σ**) is a measure that is used to quantify the amount of variation or dispersion of a set of data values. *A low standard deviation indicates that the data points tend to be close to the mean value of the set ($\mu=<x_i>$), while a high standard deviation indicates that the data points are spread out over a wider range of values.*

$$\sigma = \sqrt{\frac{1}{N}\sum_{i=1}^{N}(x_i - \mu)^2}, \quad \text{where} \quad \mu = \frac{1}{N}\sum_{i=1}^{N} x_i$$

Normal (Gaussian) distribution
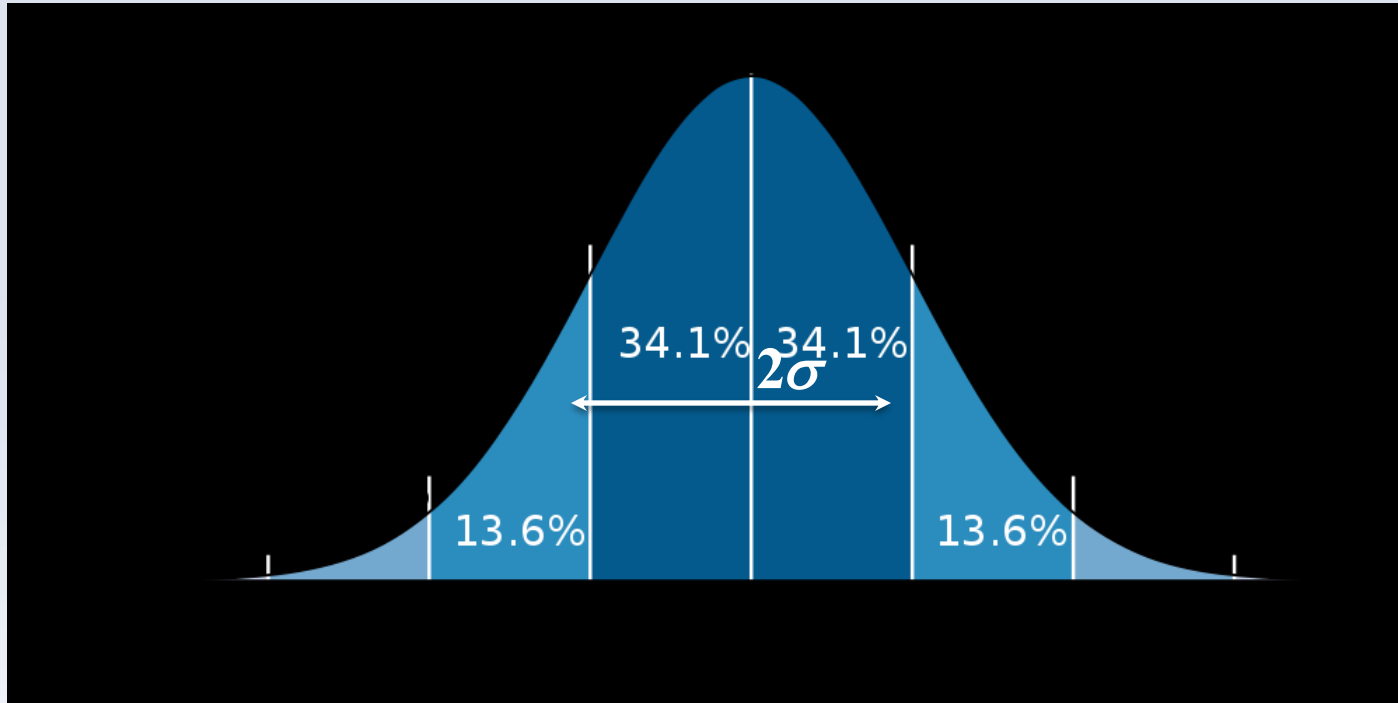
$$P_n(x) = \frac{1}{\sigma\sqrt{2\pi}} e^{-\frac{(x-\bar{x})^2}{2\sigma^2}}$$

The interval representing two standard deviations contains 95.4% of all possible true values.

Confidence interval $\langle x \rangle \pm 3\sigma$ contains 99.7% of possible outcomes.

Notations

Use of concise notation:

If, for example the average value of the speed is v = 1 234.567 89 m/s and and the standard deviation is Δv = 0.000 11 m/s (here m/s are the units of v), then we write v = (1 234.567 89 ± 0.000 11) m/s.

A more concise form of this expression, and one that is used sometimes, is v = 1 234.567 89(11) m/s, where it understood that the number in parentheses is the numerical value of the standard uncertainty referred to the corresponding last digits of the quoted result.
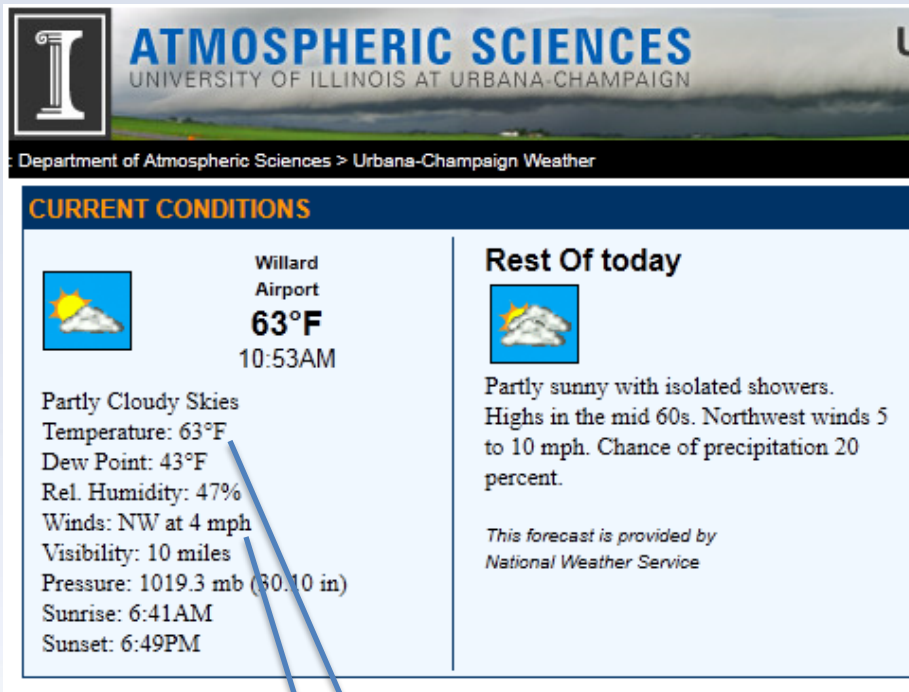
Examples of results which **do not make sense** (too many digits):

v = (1234.5678934534940945 ± 0.011) m/s

or v = (1234.56 ± 2) m/s

Significant digits

$T = 63°F\pm?$ $\longrightarrow$ **Best guess $\Delta T \sim 0.5°$F**

Wind speed 4mph$\pm$? $\rightarrow$ **Best guess $\pm 0.5 mph$**

If they say T=63.32456 F, that would be wrong
since it is not possible to predict or even measure the temperature at our campus
with such high precision.

It is important to know uncertainties in science

FIG. 70.
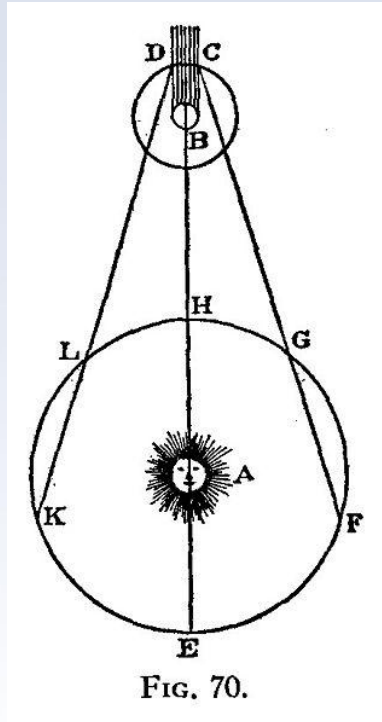
Measurement of the speed of the light

1675 Ole Roemer: 220,000 Km/sec

Ole Christensen Rømer
1644-1710

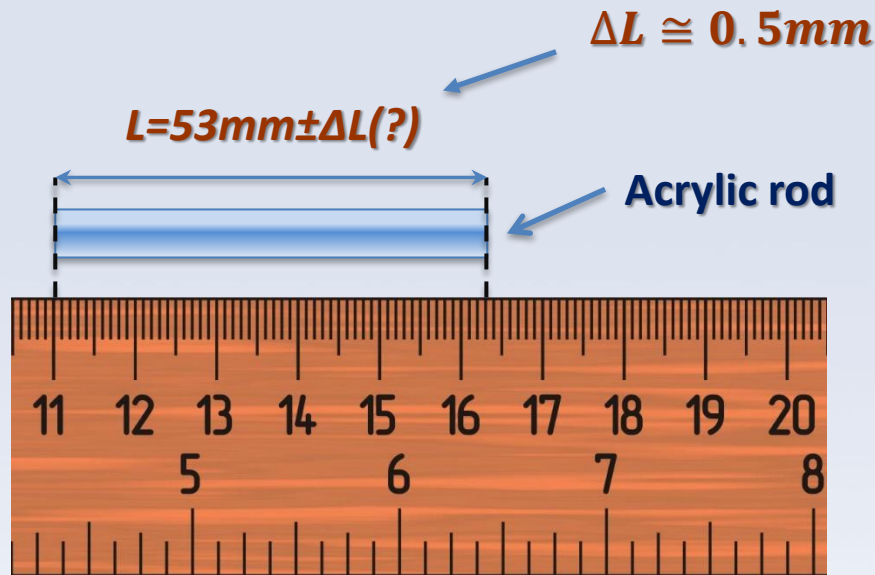**Does it make sense?**
What is missing?

Maxwell's theory prediction:
The speed of light does not depend on the light wavelength, frequency or color. It is a universal constant.
NIST Bolder Colorado c = 299,792,456.2±1.1 m/s.

Reading error

$$\Delta L \cong 0.5mm$$

L=53mm±ΔL(?)

$$\Delta L \cong 0.03mm$$

Acrylic rod

How far we have to go in reducing the reading error?

Use a simple ruler if you do not care about accuracy better than 1mm

Otherwise you need to use digital calipers

Wooden ruler is not very accurate because it has a large thermal expension coefficient.

**Reading Error = $\pm \frac{1}{2}$ (least count or minimum gradation).**

Accuracy and precession

The accuracy of an experiment is a measure of how close the result of the experiment comes to the true value

Precision refers to how closely individual measurements agree with each other

Accuracy and precession

Not Precise, Not Accurte

Precise, Not Accurate

Accurate, Not Precise

Accurate, Precise
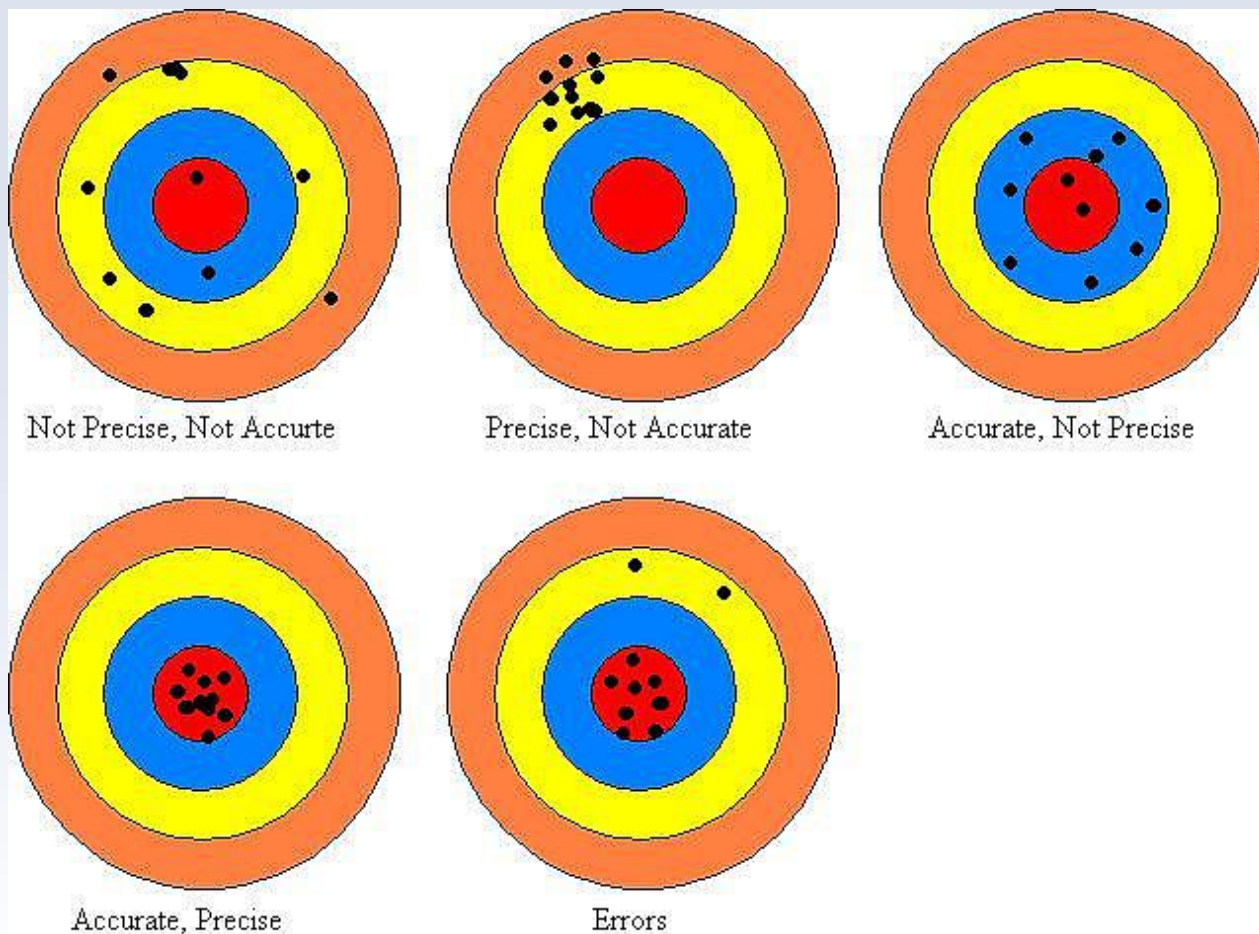
Errors

Reading error. Digital meters.

Fluke 8845A multimeter

Example Vdc (reading)=0.85V

$$\Delta V = 0.85 \times (1.8 \times 10^{-5}) + 1 \times (6 \times 10^{-6}) \sim 20\mu V$$

8846A Accuracy

Accuracy is given as ± (% measurement + % of range)

Range	24 Hour (23 ±1 °C)	90 Days (23 ±5 °C)	1 Year (23 ±5 °C)	Temperature Coefficient/ °C Outside 18 to 28 °C
100 mV	0.0025 + 0.003	0.0025 + 0.0035	0.0037 + 0.0035	0.0005 + 0.0005
1 V	0.0018 + 0.0006	0.0018 + 0.0007	0.0025 + 0.0007	0.0005 + 0.0001
10 V	0.0013 + 0.0004	0.0018 + 0.0005	0.0024 + 0.0005	0.0005 + 0.0001
100 V	0.0018 + 0.0006	0.0027 + 0.0006	0.0038 + 0.0006	0.0005 + 0.0001
1000 V	0.0018 + 0.0006	0.0031 + 0.001	0.0041 + 0.001	0.0005 + 0.0001

Presentation of the results. Reports/publications. Condenced Matter Physics.
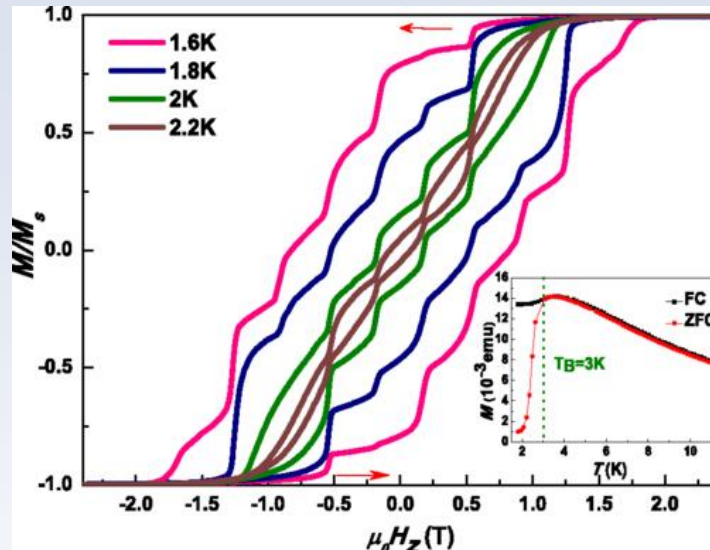
Figure 3.Magnetization (M/Ms) of Mn3 single crystal versus applied magnetic field with the sweeping rate of 0.003 T/s at different temperatures. The inset shows ZFC and FC curves.
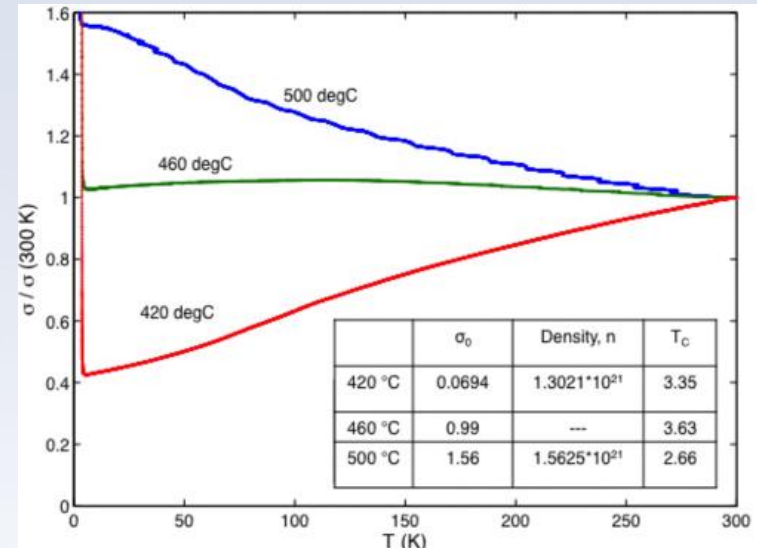
Phys. Rev. B 89, 184401

Figure 2. Normalized conductivity vs temperature for three 250-nm-thick K0.33WO3–y films on YSZ substrates. The films are annealed in vacuum at different temperatures, with properties shown in the inset table. The units of T_{anneal} are degrees Celcius, σ0 is given in 1/mΩcm, n in /cm3, and Tc in degrees Kelvin.

Phys. Rev. B 89, 184501

Presentation of the results. Reports/publications. Particle Physics.
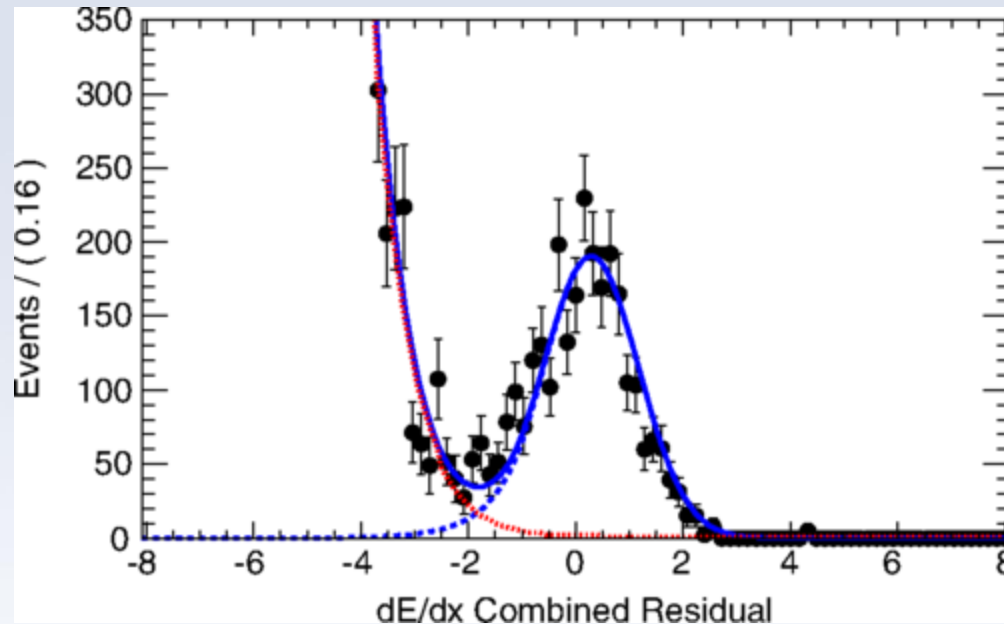
Figure 1. Normalized residuals of the combined dE/dx for antideuteron candidates in the Onpeak Υ(2S) data sample, with fit PDFs superimposed. Entries have been weighted, as detailed in the text. The solid (blue) line is the total fit, the dashed (blue) line is the d̄ signal peak, and the dotted (red) line is the background.
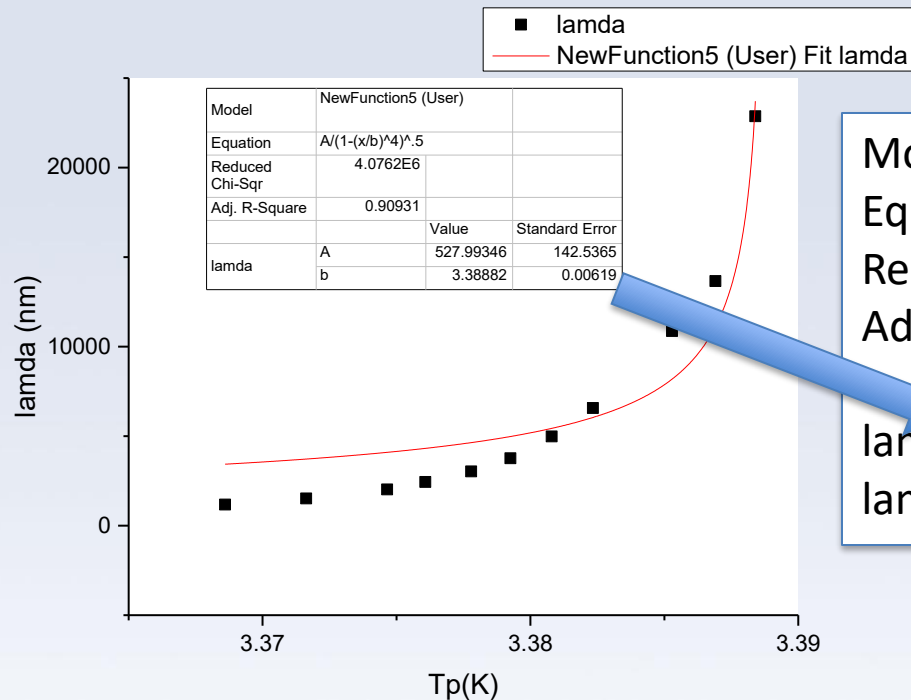
Phys. Rev. D 89, 111102(R)

Presentation of the results. Student Reports.

Figure 10(ii): lambda versus T for indium film with thickness 300 nm. Input voltage is 0.2v. Critical temperature(b) and penetration depth(A) at temperature 0 K is determined

Model	NewFunction5 (User)	
Equation	A/(1-(x/b)^4)^.5	
Reduced Chi-Sqr	4.0762E6	
Adj. R-Square	0.90931	
	Value	Standard Error
lamda A	527.99346	142.5365
lamda b	3.38882	0.00619

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1. Units must be written
2. Number of digits must be reasonable

Formula for the fitting curve must be provided

Random errors. Poisson distribution

$$P_n(t) = \frac{(rt)^n}{n!} e^{-rt} \qquad n = 0, 1, 2, \ldots$$

Siméon Denis Poisson (1781-1840)

r: decay rate (number of events per second) [counts/s]

t: time interval [s]

➔ **$P_n(rt)$** : Probability to have **n** decays in time interval **t**
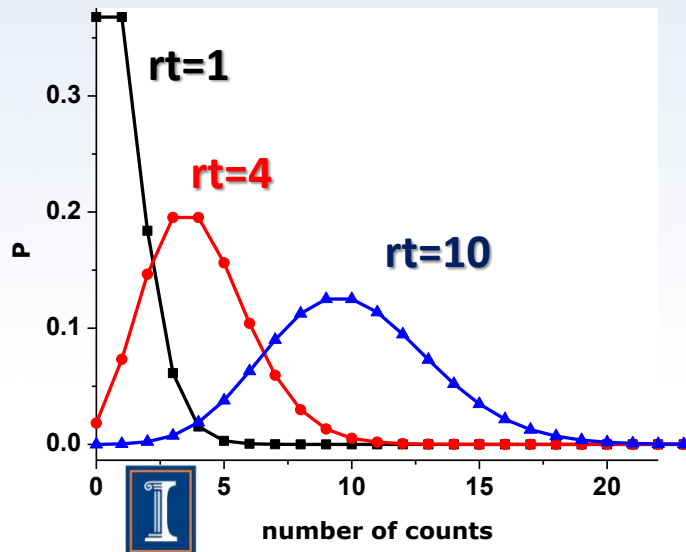
A statistical process is described through a Poisson Distribution if:

- **random process** ➔ for a given nucleus probability for a decay to occur is the same in each time interval.
- **universal probability** ➔ the probability to decay in a given time interval is same for all nuclei. Number of nuclei assumed constant.
- **no correlation between two instances** (the decay of on nucleus does not change the probability for a second nucleus to decay.)

Poisson distribution

$$P_n(t) = \frac{(rt)^n}{n!} e^{-rt} \qquad n = 0, 1, 2, \ldots$$

r: decay rate [counts/s] t: time interval [s]

➔ $P_n(rt)$: Probability to have n decays in time interval t

rt=10

$<n> = rt$

$\sigma = \sqrt{rt}$

P

number of counts
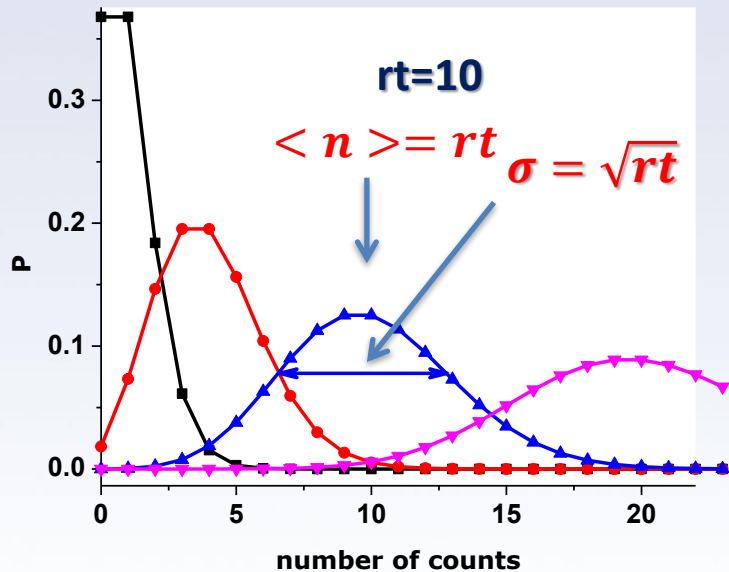
Properties of the Poisson distribution:

$$\sum_{n=0}^{\infty} P_n(rt) = 1 \quad , \quad \text{probabilities sum to 1}$$

$$<n> = \sum_{n=0}^{\infty} n \cdot P_n(rt) = rt \quad , \quad \text{the mean}$$

$$\sigma = \sqrt{\sum_{n=0}^{\infty} (n - <n>)^2 P_n(rt)} = \sqrt{rt} = \sqrt{n} \quad ,$$

standard deviation

Poisson distribution at large *rt*

$$P_n(t) = \frac{(rt)^n}{n!} e^{-rt} \quad n = 0,1,2,\ldots$$

Poisson and Gaussian distributions

- "Poisson distribution"
- — "Gaussian distribution"

Carl Friedrich Gauss (1777–1855)
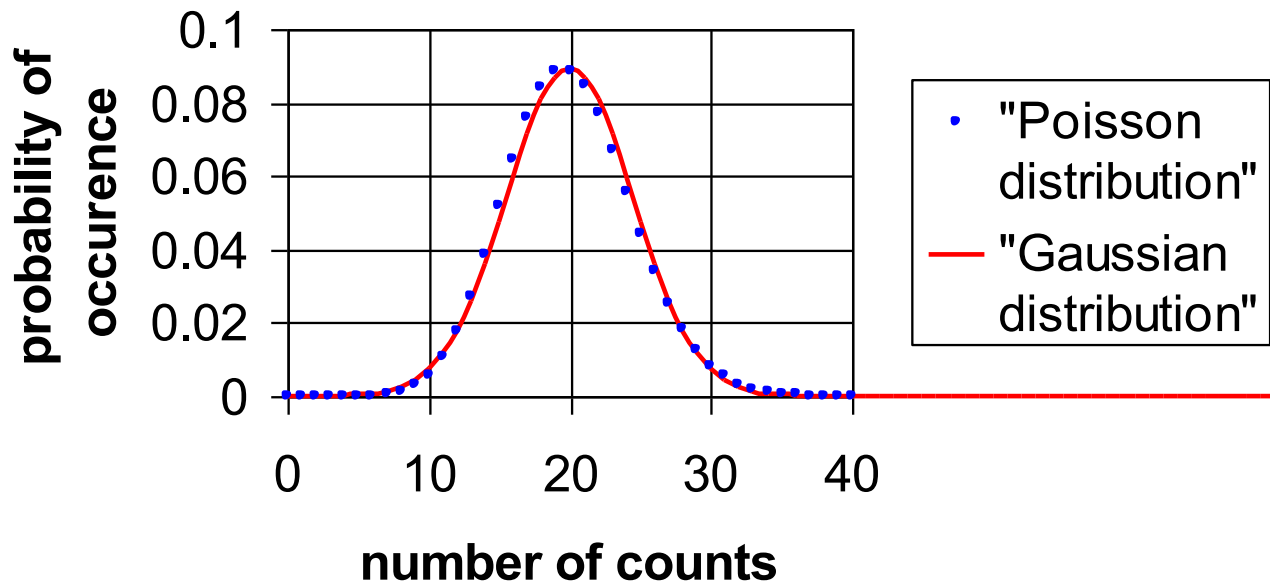
$$P_n(x) = \frac{1}{\sigma\sqrt{2\pi}} e^{-\frac{(x-\bar{x})^2}{2\sigma^2}}$$

Gaussian distribution: continuous

Measurement in presence of noise:
perform averaging to reduce the standard error

Source of noisy signal
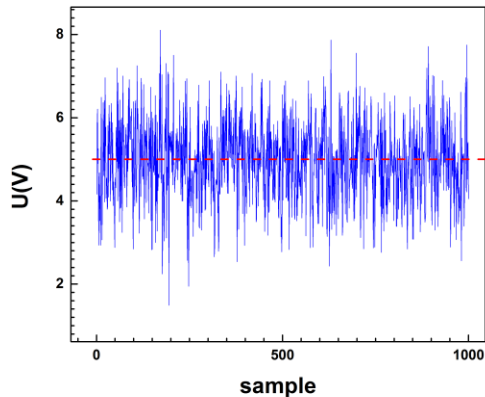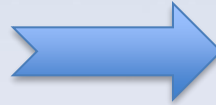
4.89855
5.25111
2.93382
4.31753
4.67903   **Expected value 5V**
3.52626
4.12001
2.93411

Actual measured values

Measurement in presence of noise
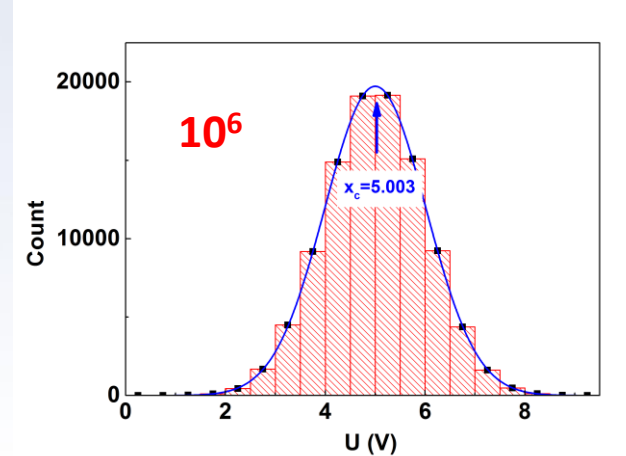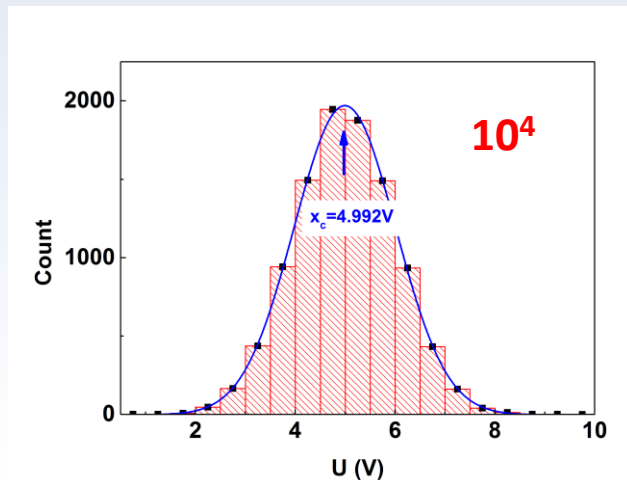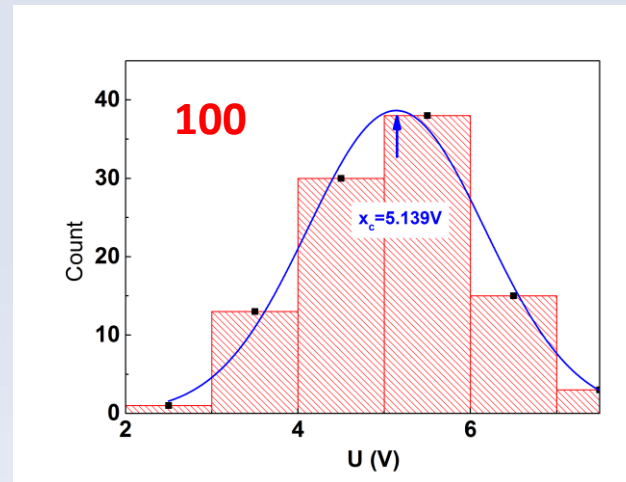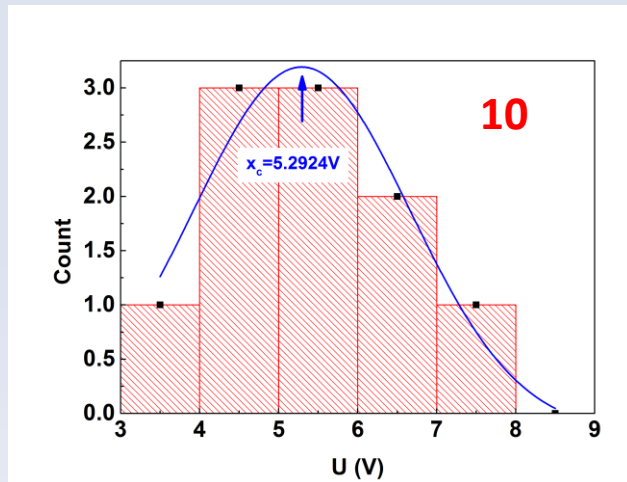
Error in the mean is given as $\dfrac{\sigma 0}{\sqrt{N}}$ (This is called standard quantum limit or the shot noise limit or "standard error")

Measurement in presence of noise
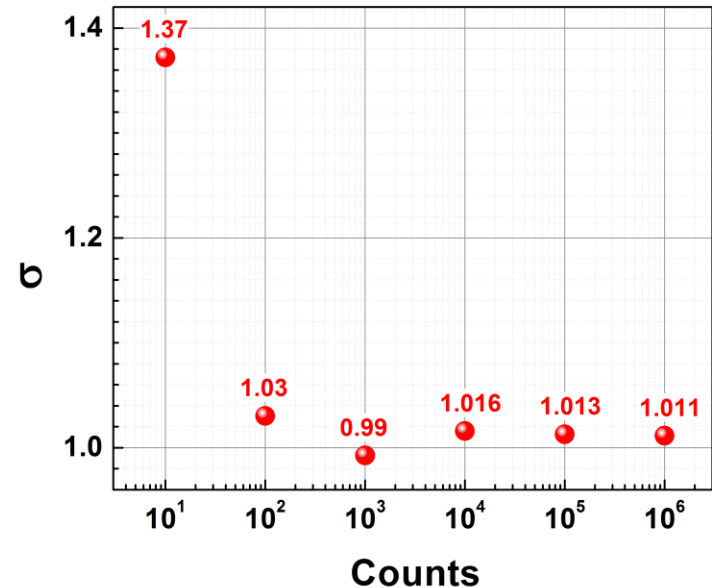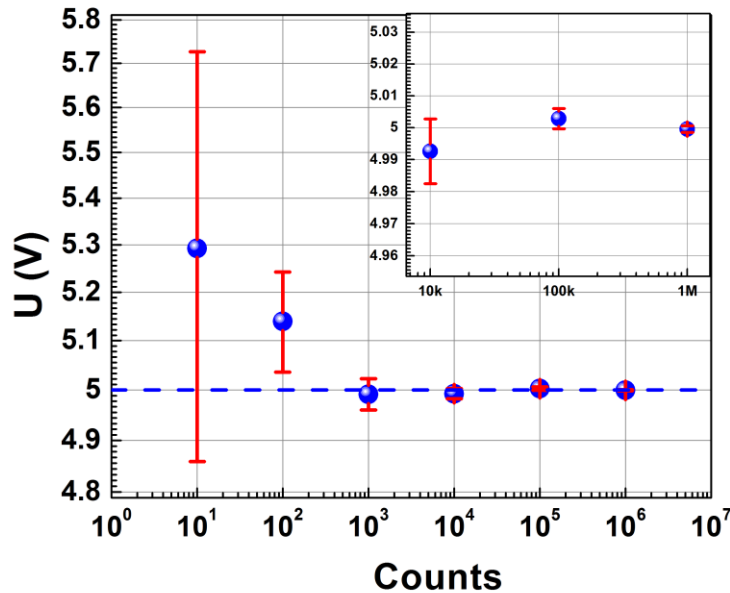
Result $\longrightarrow$ $U = x_c \pm \dfrac{\sigma_0}{\sqrt{N}}$

σ_0- standard deviation
N – number of samples

For N=10^6 U=4.999±0.001   0.02% accuracy

Heisenberg limit measurments

According to Heisenberg uncertainty,

the ultimate precision of the energy measurement is $\Delta E \sim \dfrac{\hbar}{t}$

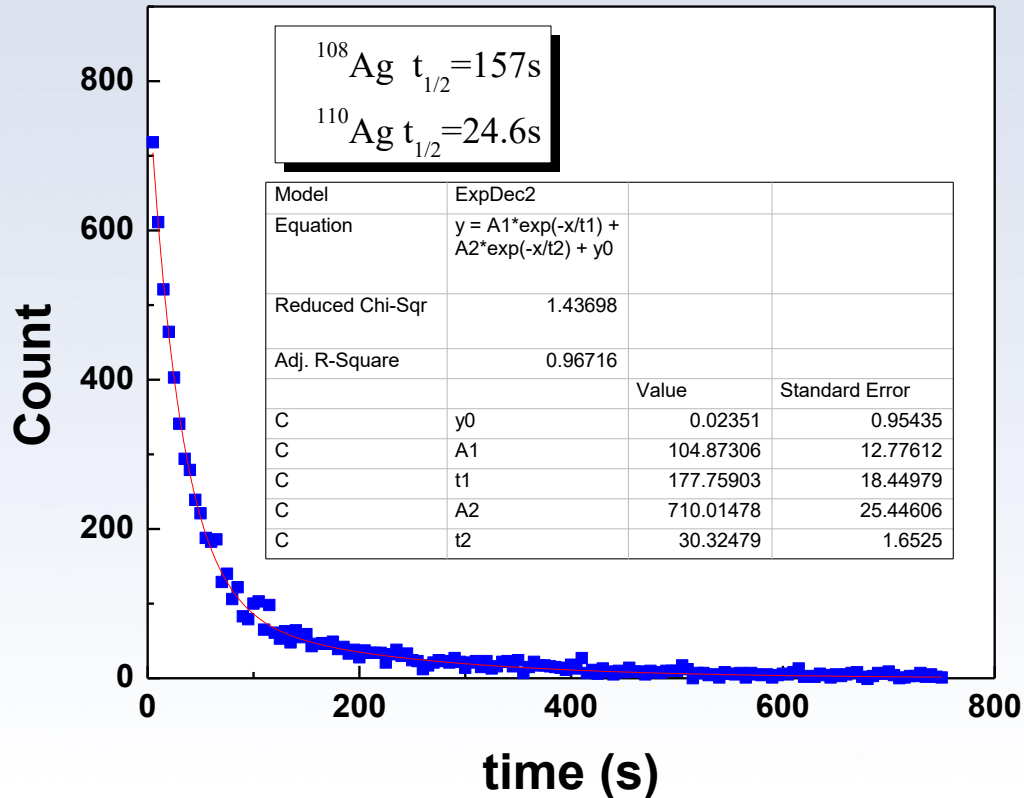If N is the number of measurements performed then $t = N * t_1$, where t_1 is the time needed to perform one measurement.

Thus the precision can be as good as $\Delta E \sim \dfrac{\hbar}{t_1} \dfrac{1}{N}$

To achieve this high precision, one must use a quantum system, such as a qubit.
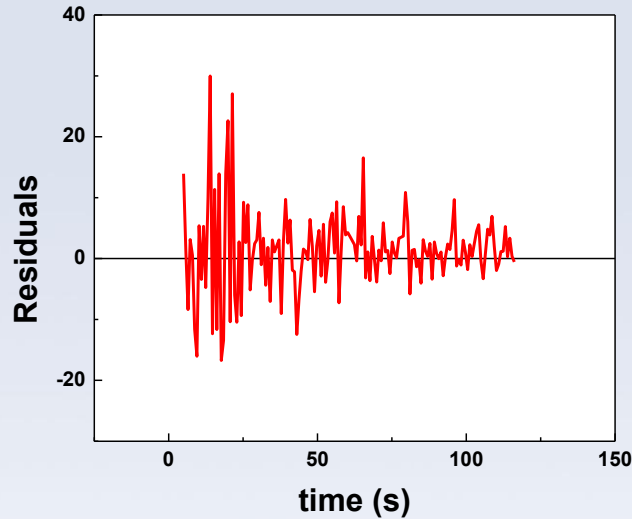
Fitting errors

Ag β decay

$$^{108}\text{Ag}\ \ t_{1/2}=157s$$
$$^{110}\text{Ag}\ t_{1/2}=24.6s$$

Model	ExpDec2		
Equation	y = A1*exp(-x/t1) + A2*exp(-x/t2) + y0		
Reduced Chi-Sqr	1.43698		
Adj. R-Square	0.96716		
		Value	Standard Error
C	y0	0.02351	0.95435
C	A1	104.87306	12.77612
C	t1	177.75903	18.44979
C	A2	710.01478	25.44606
C	t2	30.32479	1.6525

$$y = A1 \bullet \exp\left(\frac{-t}{t_1}\right) + A2 \bullet \exp\left(\frac{-t}{t_2}\right) + y_0$$

Model	Gauss		
Equation	y=y0 + (A/(w*sqrt(PI/2)))*exp(-2*((x-xc)/w)^2)		
Reduced Chi-Sqr	4.77021		
Adj. R-Square	0.93464		
		Value	Standard Error
Counts	y0	1.44204	0.48702
Counts	xc	1.49992	0.19171
Counts	w	5.93398	0.40771
Counts	A	219.24559	14.47587
Counts	sigma	2.96699	
Counts	FWHM	6.98673	
Counts	Height	29.4798	

Fitting. Analysis of the deviations

Ag β decay

Test 1. Fourier analysis
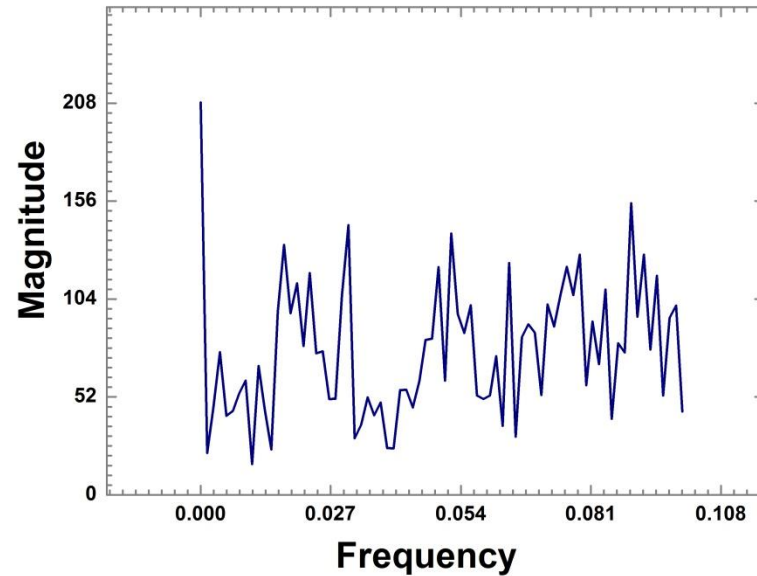
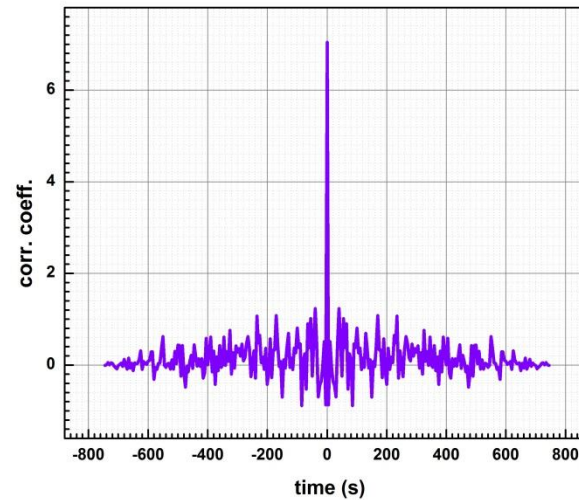**No pronounced frequencies found**

Fitting. Analysis of the residuals

Ag β decay
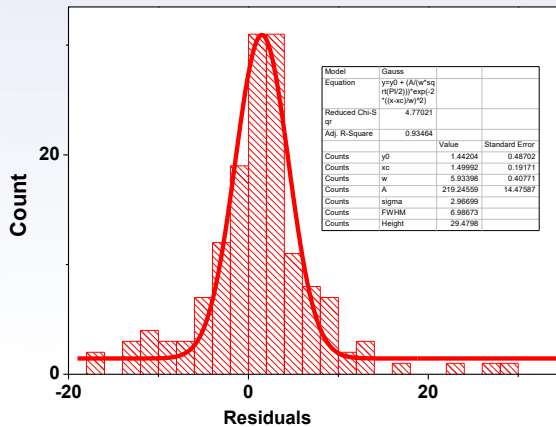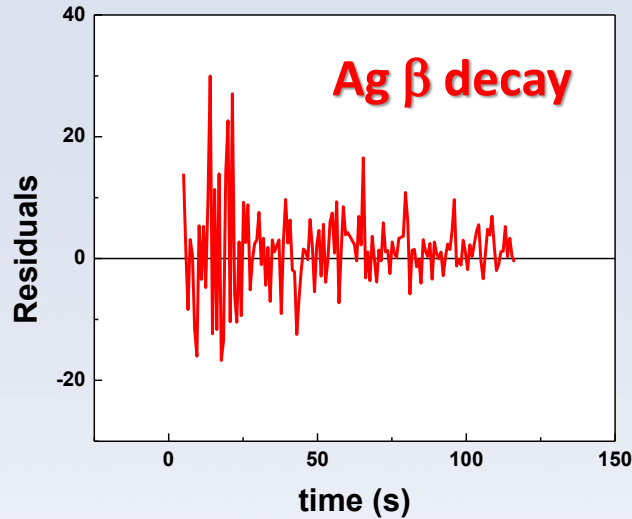
Test 1. Autocorrelation function
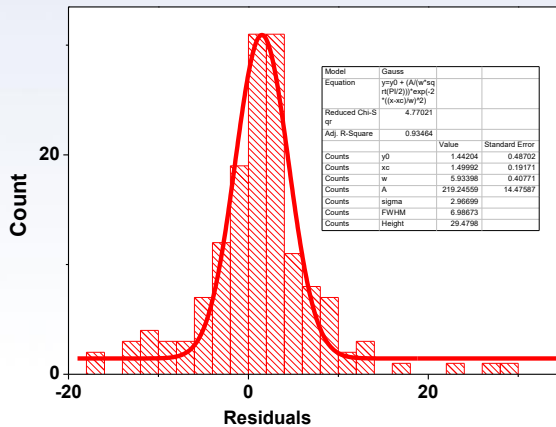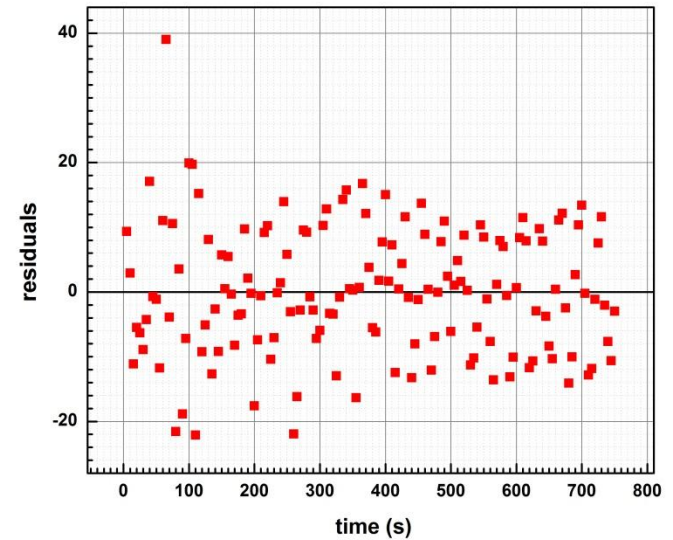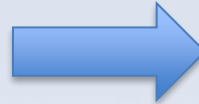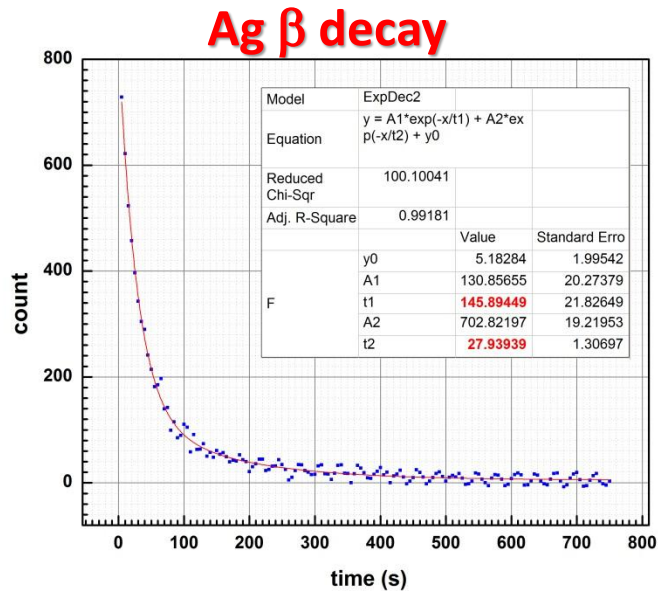

Correlation function

$$y(m) = \sum_{n=0} f(n)g(n-m)$$

autocorrelation function

$$y(m) = \sum_{n=0}^{M-1} f(n)f(n-m)$$

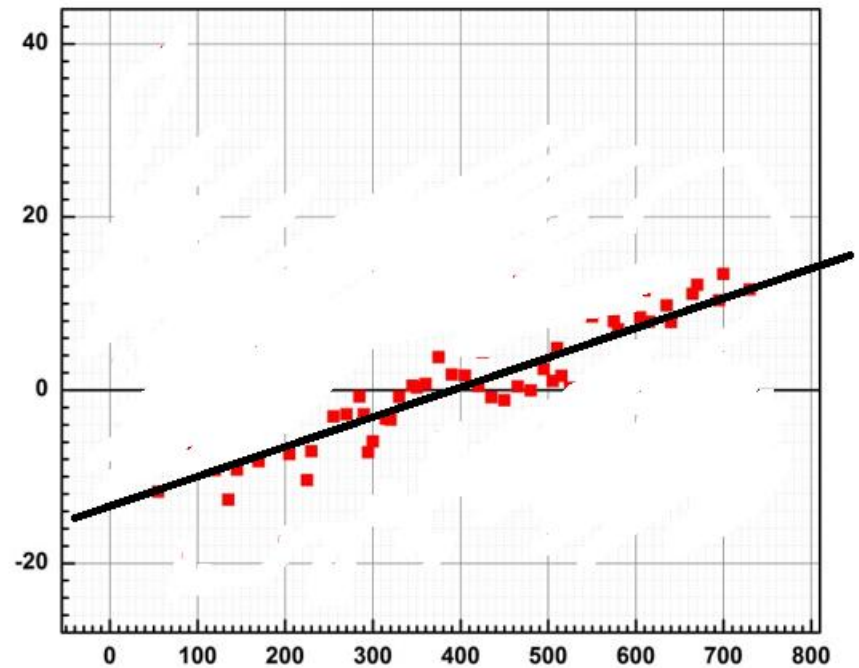# Fitting. Analysis of the residuals. Non "ideal" case

Ag β decay

Model	ExpDec2	
Equation	y = A1*exp(-x/t1) + A2*exp(-x/t2) + y0	
Reduced Chi-Sqr	100.10041	
Adj. R-Square	0.99181	
	Value	Standard Erro
y0	5.18284	1.99542
A1	130.85655	20.27379
F t1	145.89449	21.82649
A2	702.82197	19.21953
t2	27.93939	1.30697

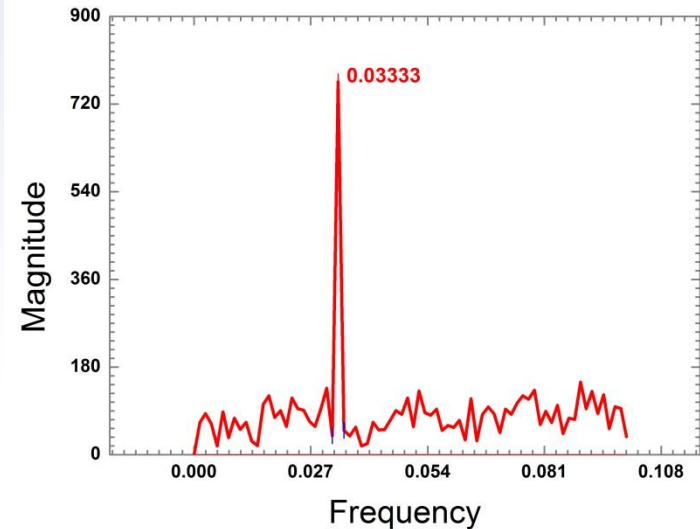|	Clear experiment	Data + "noise"
t_1(s)	177.76	145.89
t_2(s)	30.32	27.94

Note: deleting data is not allowed of course
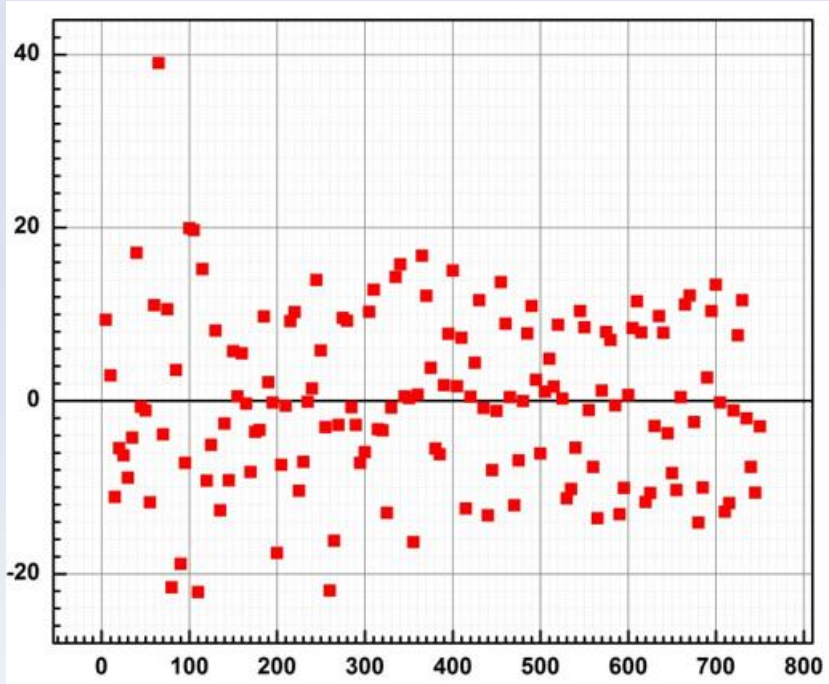
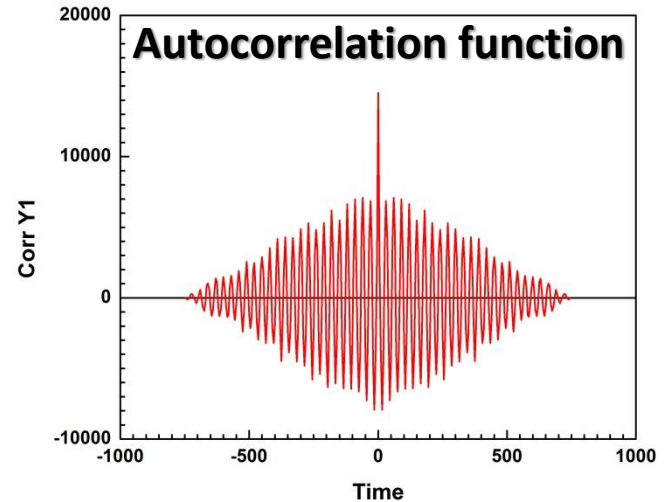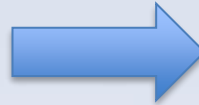Deleting data point might confirm any model, but such data manipulation is strictly forbidden in science.

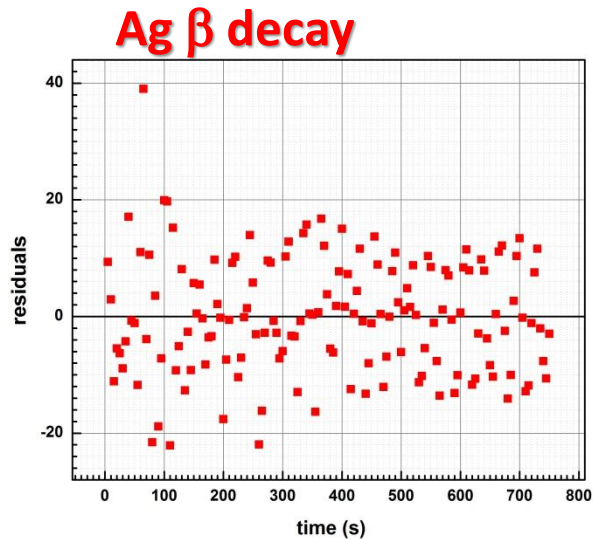physics 403

Ag β decay
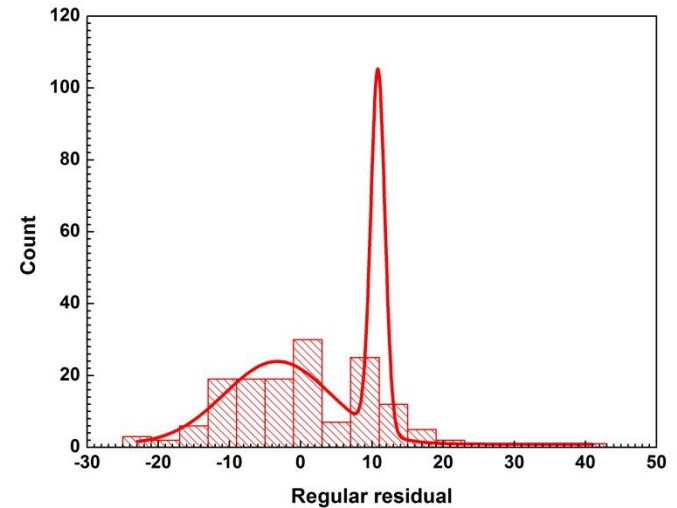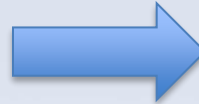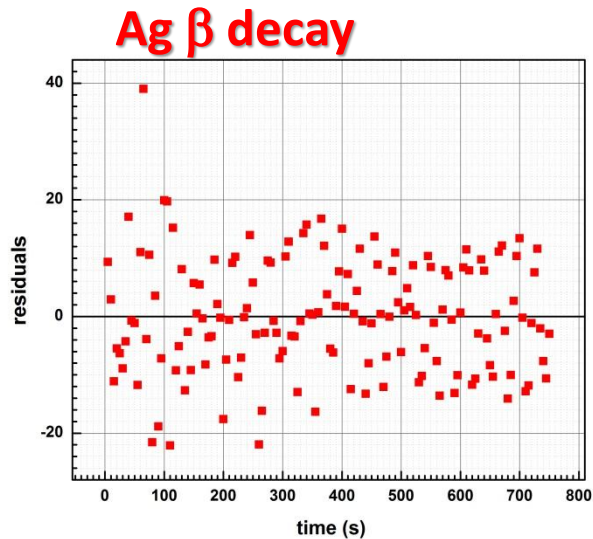
Histogram does not follow the normal distribution and there is frequency of 0.333 is present in spectrum

Fitting. Analysis of the residuals. Non "ideal" case

Ag β decay
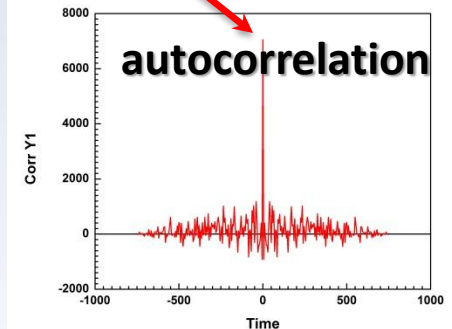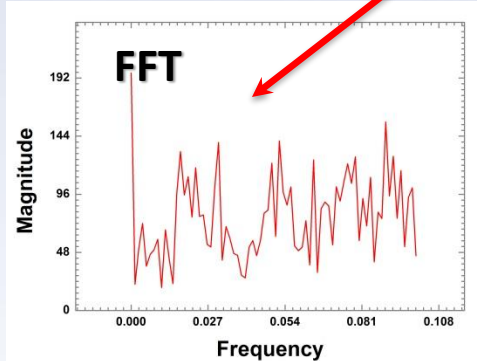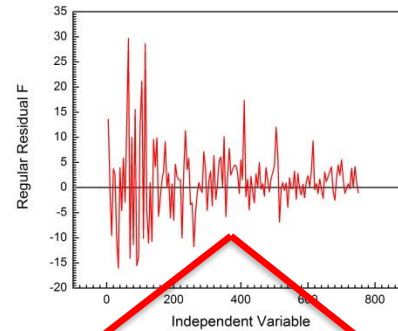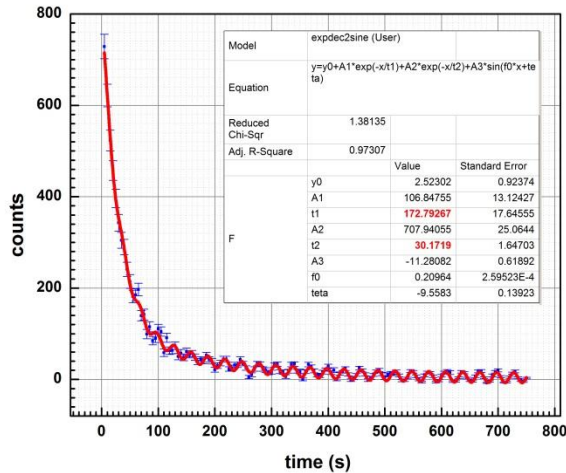

Autocorrelation function

Conclusion: fitting function should be modified by adding an additional term:

$$y(t) = y_0 + A_1 \exp\left(\frac{-t}{t_1}\right) + A_2 \exp\left(\frac{-t}{t_2}\right) + A_3 \sin(\omega t + \theta)$$
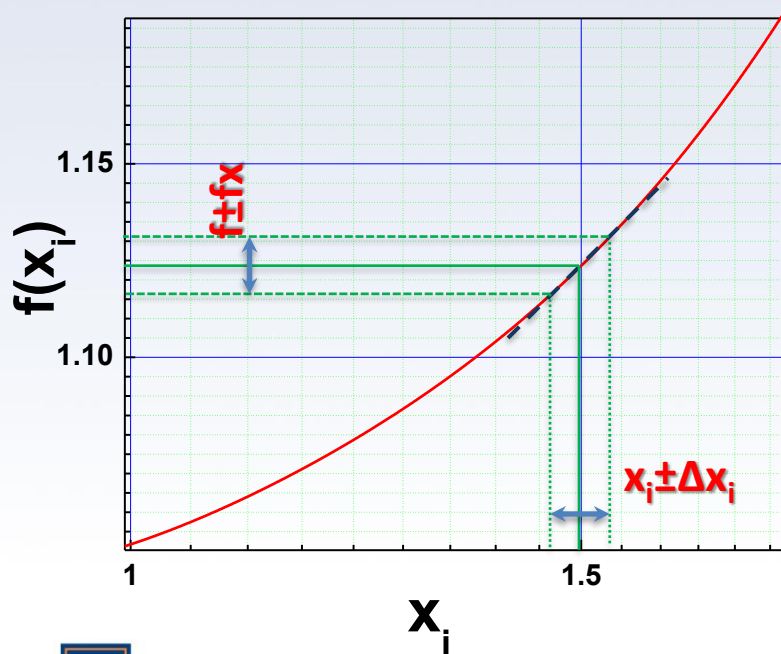
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FFT

autocorrelation

	Clear experiment	Data + noise	Modified fitting
t_1(s)	177.76	145.89	172.79
t_2(s)	30.32	27.94	30.17

Error propagation

y = f(x1, x2 … xn)

$$\Delta f(x_i, \Delta x_i) = \sqrt{\sum_{i=1}^{n} \left[\frac{\partial f}{\partial x_i} \right]^2 \cdot \Delta x_i^2}$$

Error propagation. Example.

$$f(L, C) = \frac{1}{2\pi} \sqrt{\frac{1}{LC}}$$

Derive resonance frequency f from measured inductance $L \pm \Delta L$ and capacitance $C \pm \Delta C$

$$L_1 = 10 \pm 1 \text{mH}, \quad C_1 = 10 \pm 2\mu\text{F}$$

$$\Delta f(L, C, \Delta L, \Delta C) = \sqrt{\left[\frac{\partial f}{\partial L}\right]^2 \cdot \Delta L^2 + \left[\frac{\partial f}{\partial C}\right]^2 \Delta C^2}$$

$$\frac{\partial f}{\partial L} = \frac{-1}{4\pi} C^{-\frac{1}{2}} L^{-\frac{3}{2}};$$

$$\frac{\partial f}{\partial C} = \frac{-1}{4\pi} L^{-\frac{1}{2}} C^{-\frac{3}{2}}$$

Results:
f(L$_1$,C$_1$)=503.29212104487Hz
Δf=56.26977Hz

f(L$_1$,C$_1$)=503±56Hz

THE END